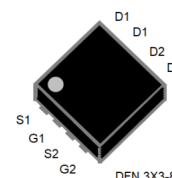
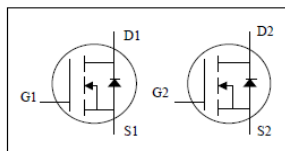


- Simple Drive Requirement
- Fast Switching Characteristic
- RoHS Compliant & Halogen-Free

BVDSS	30V
RDS(ON)typ	8.5mΩ



Description

KE9206 is from Kingeavy innovated design and silicon process technology to achieve the lowest possible on- resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

Absolute Maximum Ratings@T_J=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Drain Current, V _{GS} @ 10V	25	A
I _D @T _C =100°C	Drain Current, V _{GS} @ 10V	15	A
I _D @T _A =25°C	Drain Current, V _{GS} @ 10V	12	A
I _D @T _A =70°C	Drain Current, V _{GS} @ 10V	9	A
I _{DM}	Pulsed Drain Current ¹	70	A
EAS	Single Pulsed Avalanche Energy ²	40	mJ
P _D @T _A =25°C	Total Power Dissipation	2.5	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	0 to 150	°C

Thermal Data

Symbol	Parameter	Value	Unit
Rthj-c	Maximum Thermal Resistance, Junction-case	8	°C/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient ⁴	40	°C/W

Electrical Characteristics@T_j=25 oC(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	VGS=0V, ID=1mA	30	-	-	V
RDS(ON)	Static Drain-Source On-Resistance ³	VGS=10V, ID=10A	-	8.5	10.5	mΩ
		VGS=4.5V, ID=8A	-	12	16	mΩ
VGS(th)	Gate Threshold Voltage ³	VDS=VGS, ID=250uA	1	1.4	2.5	V
I _{DSS}	Drain-Source Leakage Current	VDS=30V, VGS=0V	-	-	1	uA
I _{GSS}	Gate-Source Leakage	VGS=±20V, VDS=0V	-	-	±100	nA
Q _g	Total Gate Charge ²	ID=10A	-	19	-	nC
Q _{gs}	Gate-Source Charge	VDS=15V	-	6.3	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	VGS=10V	-	4.5	-	nC
t _{d(on)}	Turn-on Delay Time	VDS=15V	-	6	-	ns
t _r	Rise Time	ID=10A	-	5	-	ns
t _{d(off)}	Turn-off Delay Time	RG=1Ω	-	25	-	ns
t _f	Fall Time	VGS=10V	-	7	-	ns
C _{iss}	Input Capacitance	VGS=0V	-	1011	-	pF
C _{oss}	Output Capacitance	VDS=15V	-	142	-	pF
Crss	Reverse Transfer Capacitance	f=1.0MHz	-	119	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ³	IS=10A, VGS=0V	-	-	1.2	V
I _S	Forward On Current ⁴		-	-	15	A

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.EAS Codition : T_j=25°C,VDD=15V,RG=25Ω, L=0.5mH
- 3.Pulse Test : pulse width ≤ 300uS , duty cycle ≤ 2%
- 4.Surface mounted on 1 in2 2oz copper pad of FR4 board, t < 10sec ; 135oC/W when mounted on min. copper pad.

Typical Performance Characteristics

Figure1: Output Characteristics

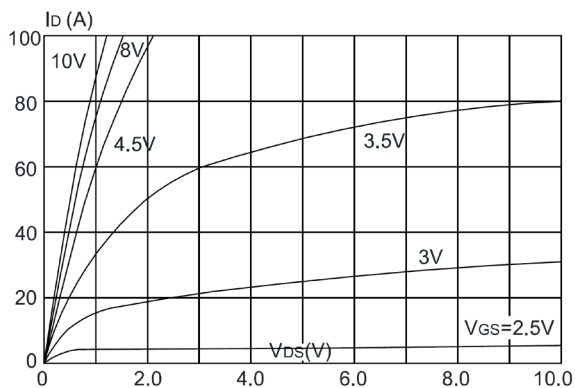


Figure2: Typical Transfer Characteristics

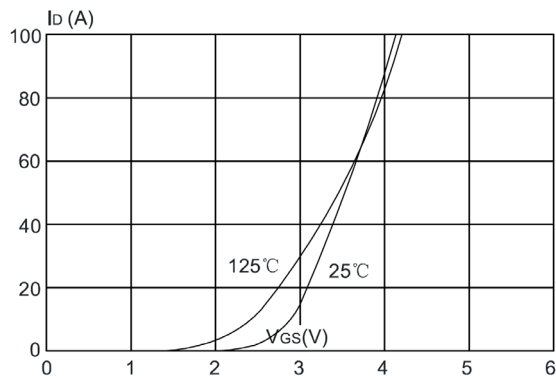


Figure3: On-resistance VS Drain Current

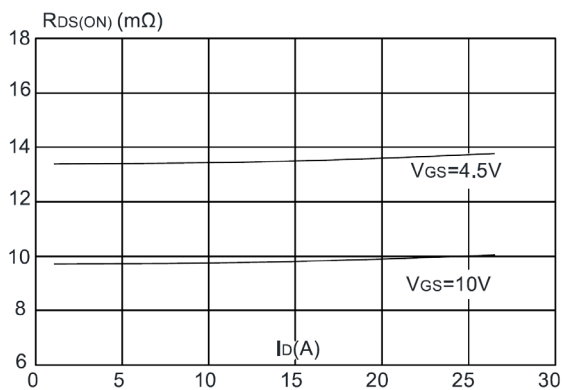


Figure4: Body Diode Characteristics

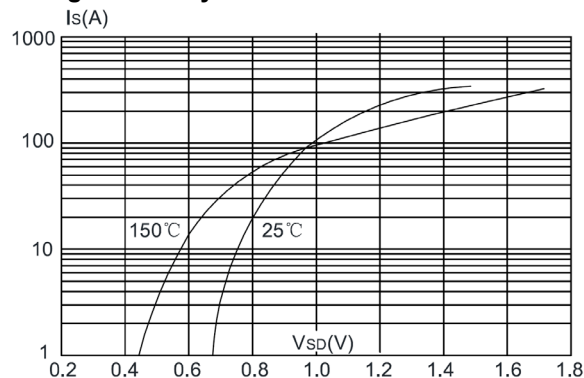


Figure5: Gate Charge Characteristics

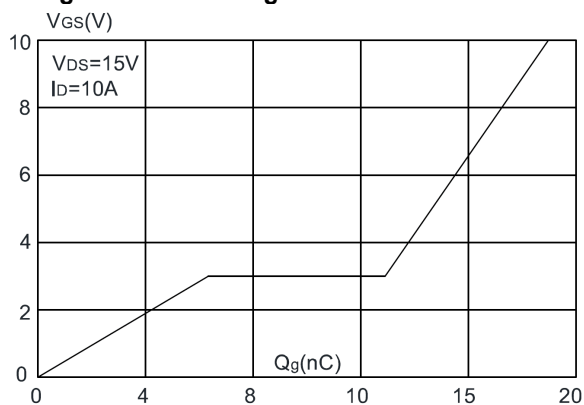


Figure6: Capacitance Characteristics

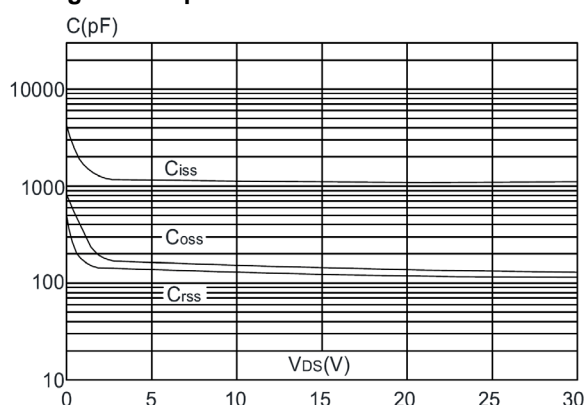


Figure7: Normalized Breakdown Voltage
VS Junction Temperature

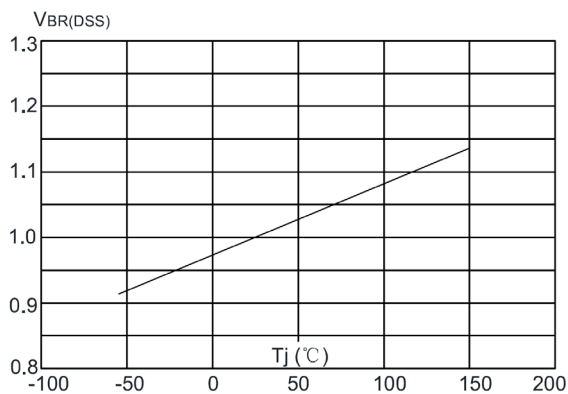


Figure8: Normalized On resistance
VS Junction Temperature

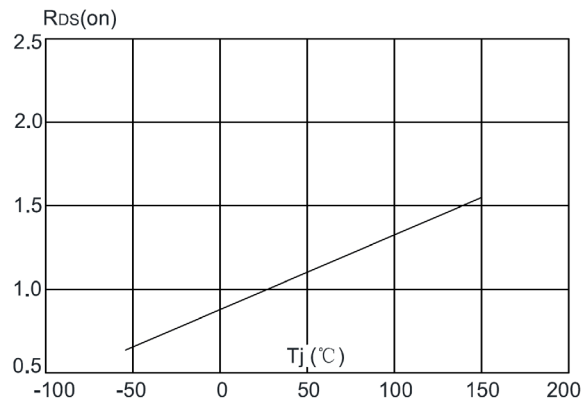


Figure9: Maximum Safe Operating Area

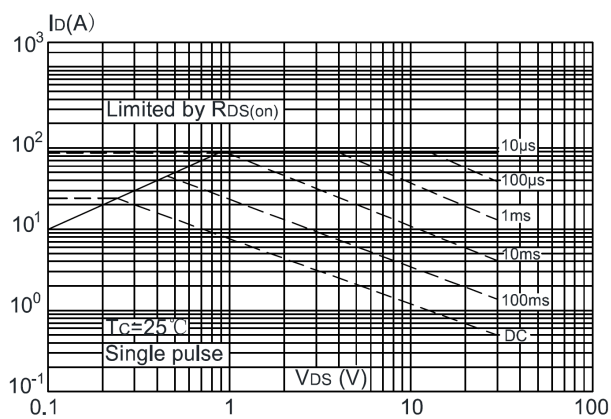
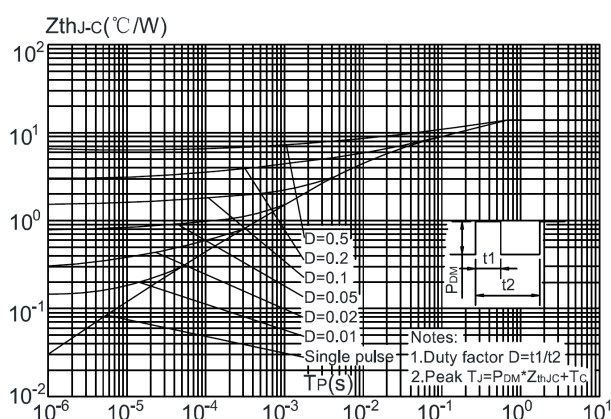
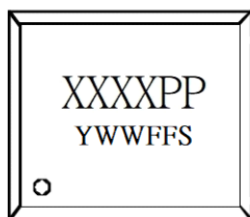


Figure10: Maximum Effective Transient Thermal



Marking Information

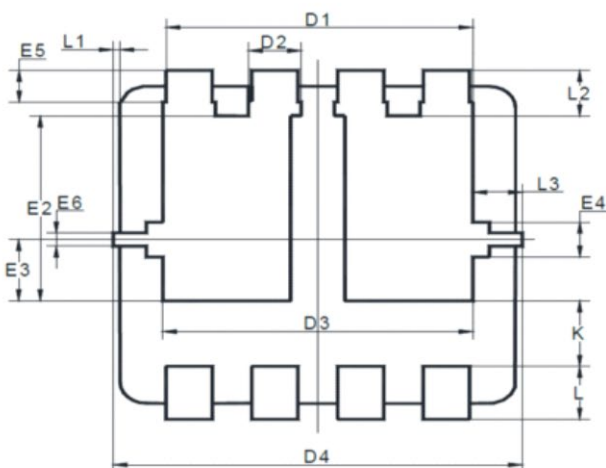
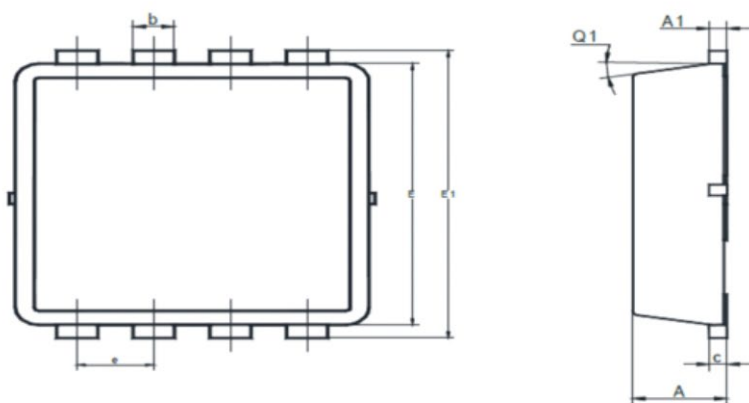


Package	DFN3x3-8	
XXXX	Part Number	
PP	Package Code	
Y	Year	E=2019 , F=2020,
WW	Weeks	Ex. 10/27=44weeks, 11/3=45weeks
FF	Wafer lot	Lot No.
S	Serial	Serial No.
Dot	First pin	

Package Outline: DFN3x3-8

Package Outline Dimensions

DFN3030.



Unit ^o	A ^o	A1 ^o	b ^o	c ^o	D1 ^o	D2 ^o	D3 ^o	D4 ^o	E ^o	E1 ^o	E2 ^o	E3 ^o	E4 ^o
mm ^o	0.9 ^o 0.7 ^o	0.05 ^o 0 ^o	0.35 ^o 0.24 ^o	0.25 ^o 0.1 ^o	2.6 ^o 2.4 ^o	0.5 ^o 0.3 ^o	2.7 ^o 2.5 ^o	3.33 ^o 3 ^o	3.1 ^o 2.9 ^o	3.5 ^o 3.1 ^o	1.85 ^o 1.65 ^o	0.68 ^o 0.48 ^o	0.43 ^o 0.23 ^o
Unit ^o	E5 ^o	E6 ^o	e ^o	K ^o	L ^o	L1 ^o	L2 ^o	L3 ^o	Ø1 ^o				
mm ^o	0.4 ^o 0.2 ^o	0.25 ^o 0.15 ^o	0.7 ^o 0.6 ^o	0.72 ^o 0.52 ^o	0.5 ^o 0.3 ^o	0.1 ^o 0 ^o	0.53 ^o 0.33 ^o	0.475 ^o 0.275 ^o	13° ^o 0° ^o				